

Abstract Submitted
for the MAR05 Meeting of
The American Physical Society

Can wide-gap chalcopyrite be doped *n*-type STEPHAN LANY, YU-JUN ZHAO, CLAS PERSSON, ALEX ZUNGER, National Renewable Energy Laboratory, Golden, CO 80401 — Wide-gap materials are more difficult to dope than their lower-gap counterparts, as evidenced by *n*-doping of Ge → Si → C or *p*-doping of GaN → AlN. Similarly, whereas CuInSe₂ ($E_g = 1.1\text{eV}$) can be *n*-doped via stoichiometry control, its wider-gap counterpart CuGaSe₂ ($E_g = 1.8\text{eV}$) so far resisted *n*-type doping. Using the defect formation energies calculated from first-principles supercell calculations, we have studied theoretically doping of CuInSe₂ and CuGaSe₂ by Cl, Br, I (on Se-site) and Zn, Cd (on metal sites), as a function of chemical thermodynamic boundary conditions. We find that the bottlenecks are proportional to (a) the ease of forming V_{Cu} (an electron killer) and (b) the ease of doping on the wrong site (e.g. Cd-on-In rather than Cd-on Cu). In CIS, halogen doping does not improve over intrinsic doping by InCu, which yields a net donor concentration of 10^{18}cm^{-3} at $T = 800\text{K}$. A higher net donor doping can be achieved with Cd and Zn doping, but a high compensation ratio is always present. In CuGaSe₂, both anion-site and cation-site donor doping is intrinsically hampered by overcompensation due to V_{Cu} formation.

Stephan Lany
National Renewable Energy Laboratory, Golden, CO 80401

Date submitted: 29 Nov 2004

Electronic form version 1.4